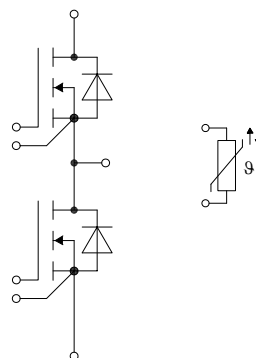
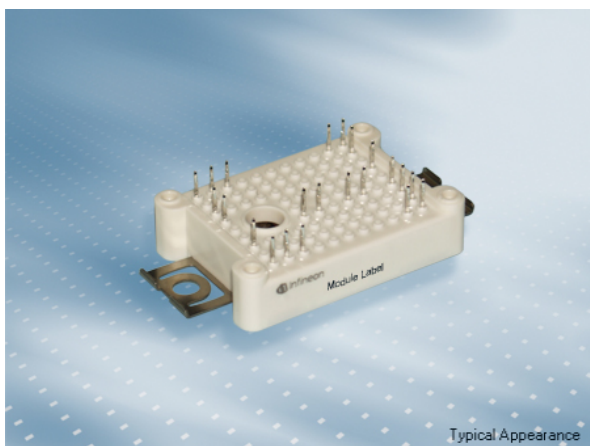


EasyDUAL Modul mit CoolSiC™ Trench MOSFET und PressFIT / NTC  
EasyDUAL module with CoolSiC™ Trench MOSFET and PressFIT / NTC

## Vorläufige Daten / Preliminary Data



$V_{DSS} = 1200V$   
 $I_{D\ nom} = 25A / I_{DRM} = 50A$

### Potentielle Anwendungen

- Anwendungen mit hohen Schaltfrequenzen
- DC/DC Wandler
- Motorantriebe
- USV-Systeme

### Elektrische Eigenschaften

- Niederinduktives Design
- Niedrige Schaltverluste

### Mechanische Eigenschaften

- Integrierter NTC Temperatur Sensor
- PressFIT Verbindungstechnik
- Robuste Montage durch integrierte Befestigungsklammern

### Potential Applications

- High Frequency Switching application
- DC/DC converter
- Motor drives
- UPS systems

### Electrical Features

- Low inductive design
- Low switching losses

### Mechanical Features

- Integrated NTC temperature sensor
- PressFIT contact technology
- Rugged mounting due to integrated mounting clamps

## Module Label Code

Barcode Code 128



DMX - Code



### Content of the Code

| Content of the Code        | Digit   |
|----------------------------|---------|
| Module Serial Number       | 1 - 5   |
| Module Material Number     | 6 - 11  |
| Production Order Number    | 12 - 19 |
| Datecode (Production Year) | 20 - 21 |
| Datecode (Production Week) | 22 - 23 |

## Vorläufige Daten Preliminary Data

### MOSFET / MOSFET

#### Höchstzulässige Werte / Maximum Rated Values

|                                               |                                                                                                                                 |                      |          |   |
|-----------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------|----------------------|----------|---|
| Drain-Source-Spannung<br>Drain-source voltage | $T_{vj} = 25^{\circ}\text{C}$                                                                                                   | $V_{DSS}$            | 1200     | V |
| Drain-Gleichstrom<br>DC drain current         | $T_{vj} = 175^{\circ}\text{C}, V_{GS} = 15\text{ V}$<br>$T_H = 75^{\circ}\text{C}$                                              | $I_{D\text{ nom}}$   | 25       | A |
| Gepulster Drainstrom<br>Pulsed drain current  | verifiziert durch Design, $t_p$ limitiert durch $T_{vj\text{ max}}$<br>verified by design, $t_p$ limited by $T_{vj\text{ max}}$ | $I_{D\text{ pulse}}$ | 50,0     | A |
| Gate-Source Spannung<br>Gate-source voltage   |                                                                                                                                 | $V_{GSS}$            | -10 / 20 | V |

#### Charakteristische Werte / Characteristic Values

| Charakteristische Werte / Characteristic Values                                  |                                                                                                                                                                                                                   |                                                                                                                   | min.               | typ. | max.                    |                           |
|----------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------|--------------------|------|-------------------------|---------------------------|
| Einschaltwiderstand<br>Drain-source on resistance                                | $I_D = 25\text{ A}$<br>$V_{GS} = 15\text{ V}$                                                                                                                                                                     | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $R_{DS\text{ on}}$ |      | 45,0<br>59,0<br>66,0    | $\text{m}\Omega$          |
| Gate-Schwellenspannung<br>Gate threshold voltage                                 | $I_D = 10,0\text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25^{\circ}\text{C}$<br>(tested after 1ms pulse at $V_{GS} = +20\text{ V}$ )                                                                                      |                                                                                                                   | $V_{GS(th)}$       | 3,45 | 4,50                    | 5,55<br>V                 |
| Gesamt Gateladung<br>Total gate charge                                           | $V_{GS} = -5\text{ V} / 15\text{ V}, V_{DS} = 600\text{ V}$                                                                                                                                                       |                                                                                                                   | $Q_G$              |      | 0,062                   | $\mu\text{C}$             |
| Interner Gatewiderstand<br>Internal gate resistor                                | $T_{vj} = 25^{\circ}\text{C}$                                                                                                                                                                                     |                                                                                                                   | $R_{Gint}$         |      | 4,0                     | $\Omega$                  |
| Eingangskapazität<br>Input capacitance                                           | $f = 1\text{ MHz}, T_{vj} = 25^{\circ}\text{C}$<br>$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, V_{AC} = 25\text{ mV}$                                                                                            |                                                                                                                   | $C_{iss}$          |      | 1,84                    | nF                        |
| Ausgangskapazität<br>Output capacitance                                          | $f = 1\text{ MHz}, T_{vj} = 25^{\circ}\text{C}$<br>$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, V_{AC} = 25\text{ mV}$                                                                                            |                                                                                                                   | $C_{oss}$          |      | 0,11                    | nF                        |
| Rückwirkungskapazität<br>Reverse transfer capacitance                            | $f = 1\text{ MHz}, T_{vj} = 25^{\circ}\text{C}$<br>$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}, V_{AC} = 25\text{ mV}$                                                                                            |                                                                                                                   | $C_{rss}$          |      | 0,014                   | nF                        |
| $C_{oss}$ Speicherenergie<br>$C_{oss}$ stored energy                             | $T_{vj} = 25^{\circ}\text{C}$<br>$V_{DS} = 800\text{ V}, V_{GS} = -5\text{ V} / 15\text{ V}$                                                                                                                      |                                                                                                                   | $E_{oss}$          |      | 44,0                    | $\mu\text{J}$             |
| Drain-Source-Reststrom<br>Zero gate voltage drain current                        | $V_{DS} = 1200\text{ V}, V_{GS} = -5\text{ V}$                                                                                                                                                                    | $T_{vj} = 25^{\circ}\text{C}$                                                                                     | $I_{DSS}$          |      | 0,10                    | 120<br>$\mu\text{A}$      |
| Gate-Source-Reststrom<br>Gate-source leakage current                             | $V_{DS} = 0\text{ V}$<br>$T_{vj} = 25^{\circ}\text{C}$                                                                                                                                                            | $V_{GS} = 20\text{ V}$<br>$V_{GS} = -10\text{ V}$                                                                 | $I_{GSS}$          |      |                         | 400<br>nA                 |
| Einschaltverzögerungszeit, induktive Last<br>Turn on delay time, inductive load  | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}$<br>$V_{GS} = -5\text{ V} / 15\text{ V}$<br>$R_{Gon} = 1,00\ \Omega$                                                                                                    | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $t_{d\text{ on}}$  |      | 8,20<br>7,40<br>7,40    | ns                        |
| Anstiegszeit, induktive Last<br>Rise time, inductive load                        | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}$<br>$V_{GS} = -5\text{ V} / 15\text{ V}$<br>$R_{Gon} = 1,00\ \Omega$                                                                                                    | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $t_r$              |      | 6,30<br>6,70<br>6,70    | ns                        |
| Abschaltverzögerungszeit, induktive Last<br>Turn off delay time, inductive load  | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}$<br>$V_{GS} = -5\text{ V} / 15\text{ V}$<br>$R_{Goff} = 1,00\ \Omega$                                                                                                   | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $t_{d\text{ off}}$ |      | 35,2<br>38,9<br>38,9    | ns                        |
| Fallzeit, induktive Last<br>Fall time, inductive load                            | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}$<br>$V_{GS} = -5\text{ V} / 15\text{ V}$<br>$R_{Goff} = 1,00\ \Omega$                                                                                                   | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $t_f$              |      | 16,4<br>16,4<br>16,4    | ns                        |
| Einschaltverlustenergie pro Puls<br>Turn-on energy loss per pulse                | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}, L_{\sigma} = 30\text{ nH}$<br>$di/dt = 5,20\text{ kA}/\mu\text{s}$ ( $T_{vj} = 150^{\circ}\text{C}$ )<br>$V_{GS} = -5\text{ V} / 15\text{ V}, R_{Gon} = 1,00\ \Omega$  | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $E_{on}$           |      | 0,30<br>0,37<br>0,37    | mJ                        |
| Abschaltverlustenergie pro Puls<br>Turn-off energy loss per pulse                | $I_D = 25\text{ A}, V_{DS} = 600\text{ V}, L_{\sigma} = 30\text{ nH}$<br>$du/dt = 41,6\text{ kV}/\mu\text{s}$ ( $T_{vj} = 150^{\circ}\text{C}$ )<br>$V_{GS} = -5\text{ V} / 15\text{ V}, R_{Goff} = 1,00\ \Omega$ | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$                 | $E_{off}$          |      | 0,033<br>0,035<br>0,035 | mJ                        |
| Kurzschlußverhalten<br>SC data                                                   | $V_{GS} = -5\text{ V} / 15\text{ V}, V_{DD} = 800\text{ V}$<br>$V_{DSmax} = V_{DSS} - L_{SDS} \cdot di/dt$<br>$R_G = 10,0\ \Omega$                                                                                | $t_P \leq 2\ \mu\text{s}, T_{vj} = 25^{\circ}\text{C}$<br>$t_P \leq 2\ \mu\text{s}, T_{vj} = 150^{\circ}\text{C}$ | $I_{SC}$           |      | 210<br>205              | A<br>A                    |
| Wärmewiderstand, Chip bis Kühlkörper<br>Thermal resistance, junction to heatsink | pro MOSFET / per MOSFET                                                                                                                                                                                           |                                                                                                                   | $R_{thJH}$         |      | 1,54                    | K/W                       |
| Temperatur im Schaltbetrieb<br>Temperature under switching conditions            |                                                                                                                                                                                                                   |                                                                                                                   | $T_{vj\text{ op}}$ | -40  |                         | 150<br>$^{\circ}\text{C}$ |

### Body Diode / Body diode

#### Höchstzulässige Werte / Maximum Rated Values

|                                                         |                                                      |                            |          |   |   |
|---------------------------------------------------------|------------------------------------------------------|----------------------------|----------|---|---|
| Body Diode-Gleichstrom<br>DC body diode forward current | $T_{vj} = 175^{\circ}\text{C}, V_{GS} = -5\text{ V}$ | $T_H = 75^{\circ}\text{C}$ | $I_{SD}$ | 8 | A |
|---------------------------------------------------------|------------------------------------------------------|----------------------------|----------|---|---|

#### Charakteristische Werte / Characteristic Values

|                                      |                                                                                                                                              |                                                                                                   | min.     | typ.                 | max. |   |
|--------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------|----------|----------------------|------|---|
| Durchlassspannung<br>Forward voltage | $I_{SD} = 25\text{ A}, V_{GS} = -5\text{ V}$<br>$I_{SD} = 25\text{ A}, V_{GS} = -5\text{ V}$<br>$I_{SD} = 25\text{ A}, V_{GS} = -5\text{ V}$ | $T_{vj} = 25^{\circ}\text{C}$<br>$T_{vj} = 125^{\circ}\text{C}$<br>$T_{vj} = 150^{\circ}\text{C}$ | $V_{SD}$ | 4,60<br>4,35<br>4,30 | 5,65 | V |

## Vorläufige Daten Preliminary Data

### NTC-Widerstand / NTC-Thermistor

#### Charakteristische Werte / Characteristic Values

|                                          |                                                                |              | min. | typ. | max. |            |
|------------------------------------------|----------------------------------------------------------------|--------------|------|------|------|------------|
| Nennwiderstand<br>Rated resistance       | $T_{NTC} = 25^{\circ}\text{C}$                                 | $R_{25}$     |      | 5,00 |      | k $\Omega$ |
| Abweichung von R100<br>Deviation of R100 | $T_{NTC} = 100^{\circ}\text{C}, R_{100} = 493 \Omega$          | $\Delta R/R$ | -5   |      | 5    | %          |
| Verlustleistung<br>Power dissipation     | $T_{NTC} = 25^{\circ}\text{C}$                                 | $P_{25}$     |      |      | 20,0 | mW         |
| B-Wert<br>B-value                        | $R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$  | $B_{25/50}$  |      | 3375 |      | K          |
| B-Wert<br>B-value                        | $R_2 = R_{25} \exp [B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$  | $B_{25/80}$  |      | 3411 |      | K          |
| B-Wert<br>B-value                        | $R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$ | $B_{25/100}$ |      | 3433 |      | K          |

Angaben gemäß gültiger Application Note.

Specification according to the valid application note.

### Modul / Module

| Isolations-Prüfspannung<br>Isolation test voltage                 | RMS, $f = 50 \text{ Hz}$ , $t = 1 \text{ min.}$                                         | $V_{ISOL}$ |      | 3,0                     |      | kV                 |
|-------------------------------------------------------------------|-----------------------------------------------------------------------------------------|------------|------|-------------------------|------|--------------------|
| Innere Isolation<br>Internal isolation                            | Basisisolation (Schutzklasse 1, EN61140)<br>basic insulation (class 1, IEC 61140)       |            |      | $\text{Al}_2\text{O}_3$ |      |                    |
| Kriechstrecke<br>Creepage distance                                | Kontakt - Kühlkörper / terminal to heatsink<br>Kontakt - Kontakt / terminal to terminal |            |      | 11,5<br>6,3             |      | mm                 |
| Luftstrecke<br>Clearance                                          | Kontakt - Kühlkörper / terminal to heatsink<br>Kontakt - Kontakt / terminal to terminal |            |      | 10,0<br>5,0             |      | mm                 |
| Vergleichszahl der Kriechwegbildung<br>Comperative tracking index |                                                                                         | CTI        |      | > 200                   |      |                    |
| Relativer Temperaturindex (elektr.)<br>RTI Elec.                  | Gehäuse<br>housing                                                                      | RTI        |      | 140                     |      | $^{\circ}\text{C}$ |
|                                                                   |                                                                                         |            | min. | typ.                    | max. |                    |
| Modulstreuinduktivität<br>Stray inductance module                 |                                                                                         | $L_{sCE}$  |      | 18                      |      | nH                 |
| Lagertemperatur<br>Storage temperature                            |                                                                                         | $T_{stg}$  | -40  |                         | 125  | $^{\circ}\text{C}$ |
| Anpresskraft für mech. Bef. pro Feder<br>mounting force per clamp |                                                                                         | F          | 20   | -                       | 50   | N                  |
| Gewicht<br>Weight                                                 |                                                                                         | G          |      | 24                      |      | g                  |

The current under continuous operation is limited to 25 A rms per connector pin.

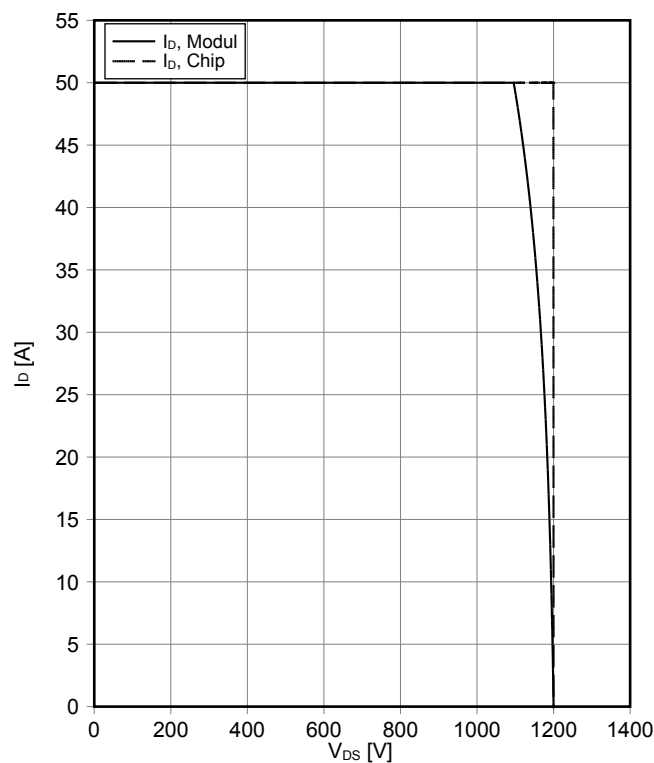
Important note: The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN 2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

## Vorläufige Daten Preliminary Data

### Sicherer Rückwärts-Arbeitsbereich MOSFET (RBSOA) reverse bias safe operating area MOSFET (RBSOA)

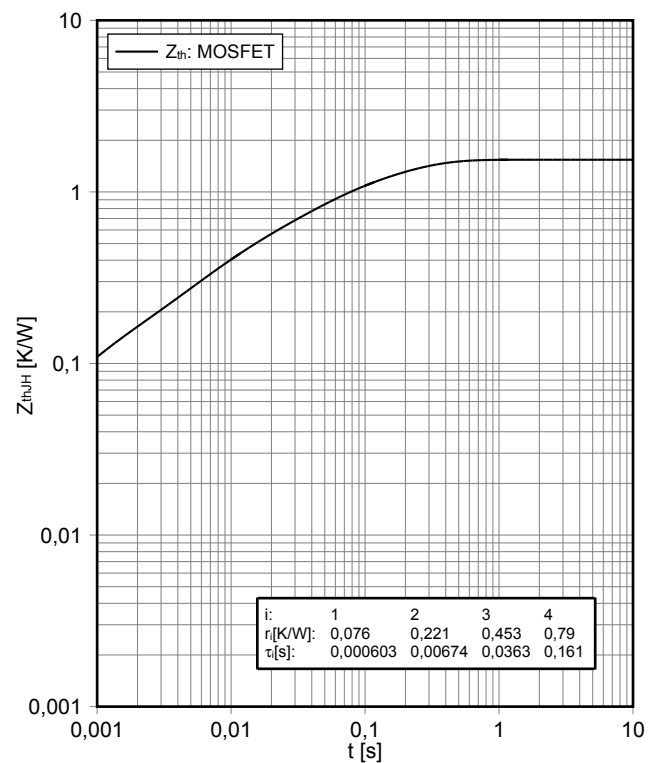
$I_D = f(V_{DS})$

$V_{GS} = -5 \text{ V} / 15 \text{ V}$ ,  $T_{vj} = 150^\circ\text{C}$ ,  $R_G = 1 \Omega$



### Transienter Wärmewiderstand MOSFET transient thermal impedance MOSFET

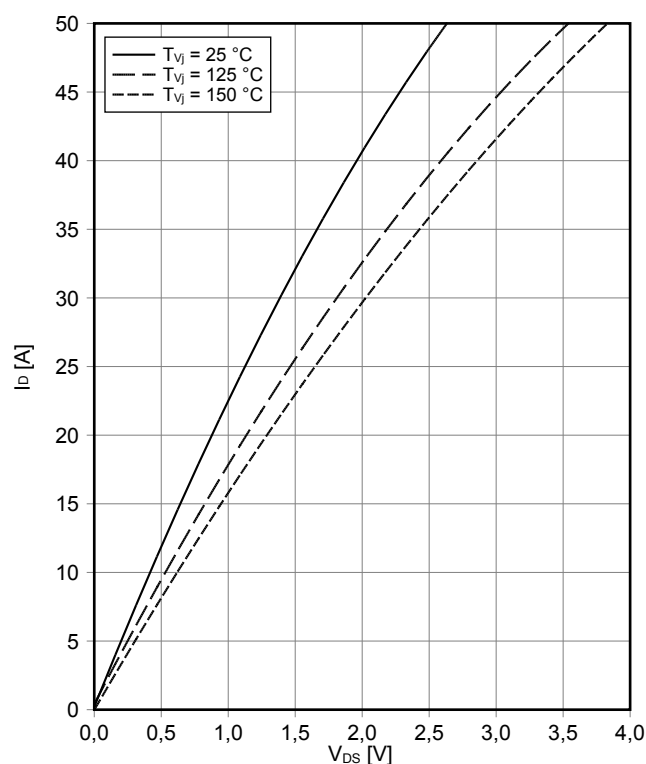
$Z_{thJH} = f(t)$



### Ausgangskennlinie MOSFET (typisch) output characteristic MOSFET (typical)

$I_D = f(V_{DS})$

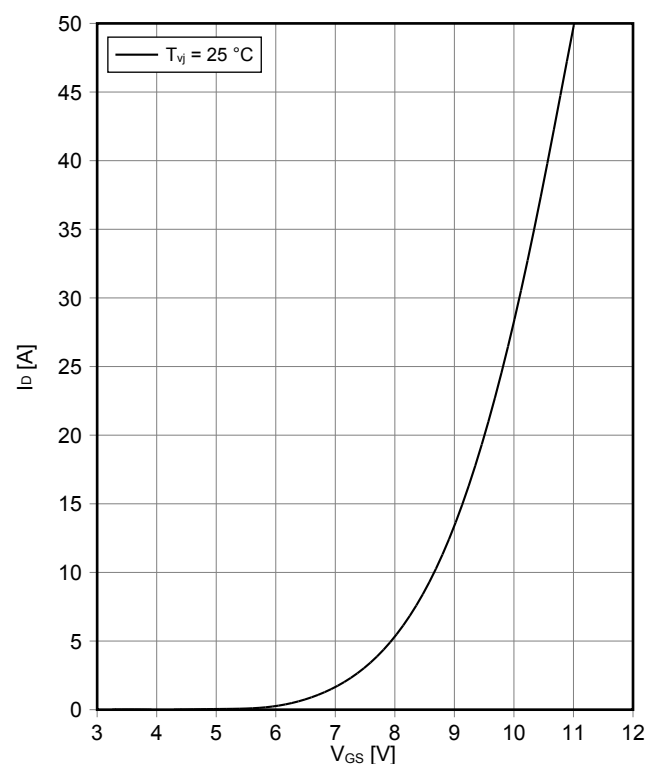
$V_{DS} = 15 \text{ V}$



### Übertragungscharakteristik MOSFET (typisch) transfer characteristic MOSFET (typical)

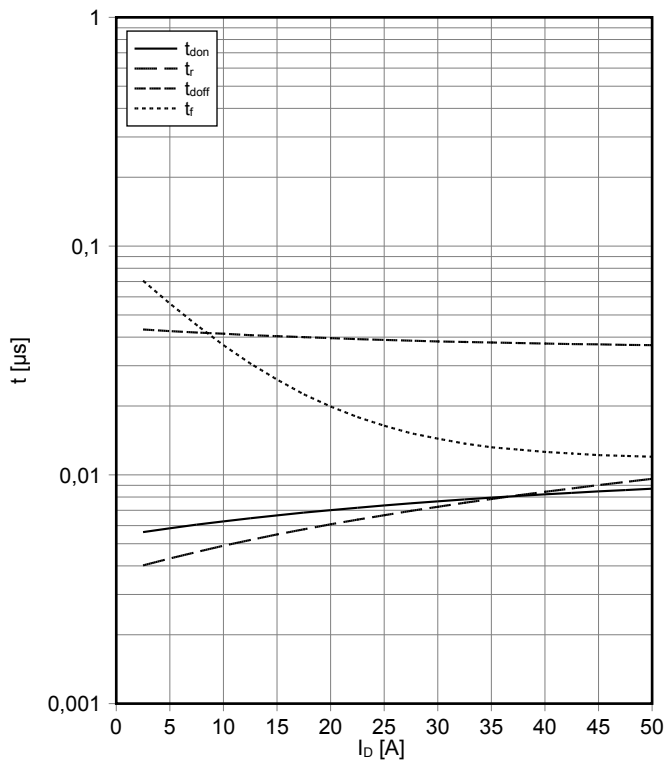
$I_D = f(V_{GS})$

$V_{DS} = 20 \text{ V}$

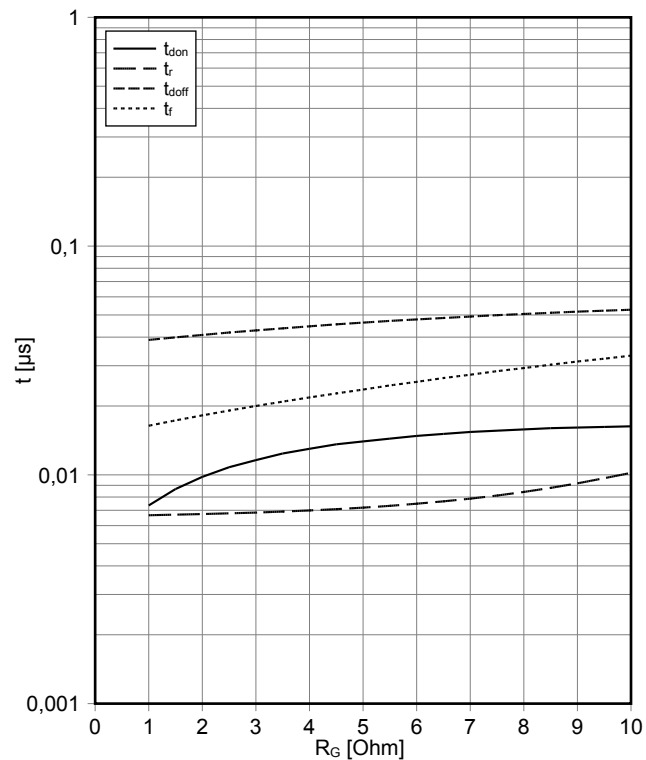


# Vorläufige Daten Preliminary Data

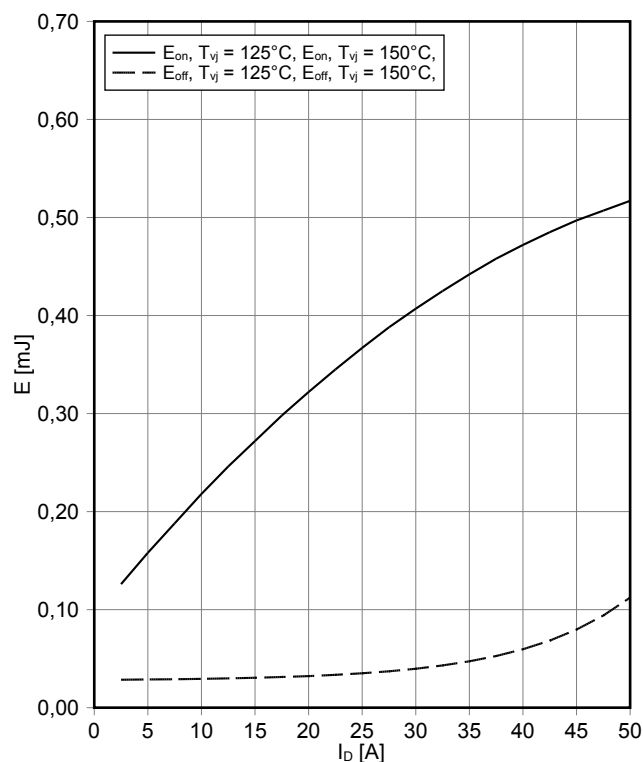
## Schaltzeiten MOSFET (typisch) switching times MOSFET (typical)

 $t_{don} = f(I_D), t_r = f(I_D), t_{doff} = f(I_D), t_f = f(I_D)$ 
 $V_{GS} = -5\text{ V} / 15\text{ V}, R_{Gon} = 1\ \Omega, R_{Goff} = 1\ \Omega, V_{DS} = 600\text{ V}, T_{vj} = 150^\circ\text{C}$ 


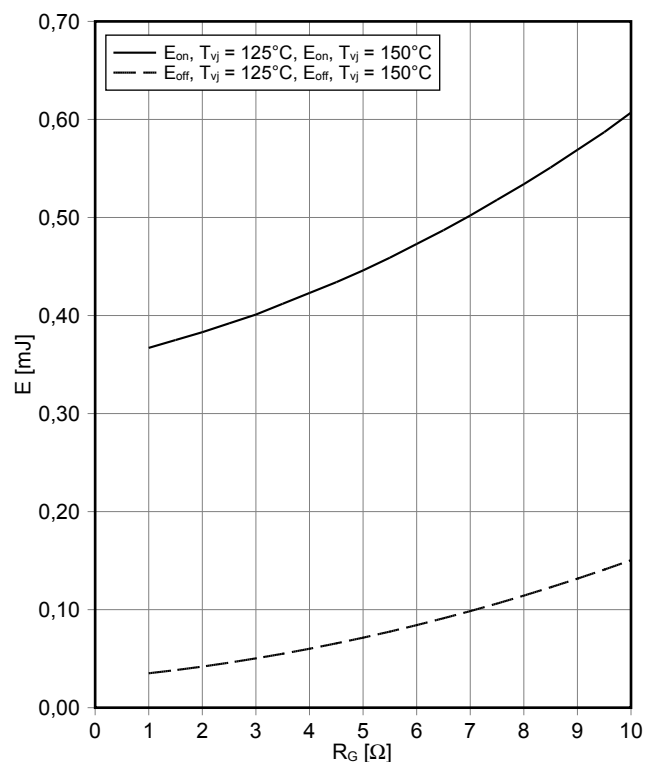
## Schaltzeiten MOSFET (typisch) switching times MOSFET (typical)

 $t_{don} = f(R_G), t_r = f(R_G), t_{doff} = f(R_G), t_f = f(R_G)$ 
 $V_{GS} = -5\text{ V} / 15\text{ V}, I_D = 25\text{ A}, V_{DS} = 600\text{ V}, T_{vj} = 150^\circ\text{C}$ 


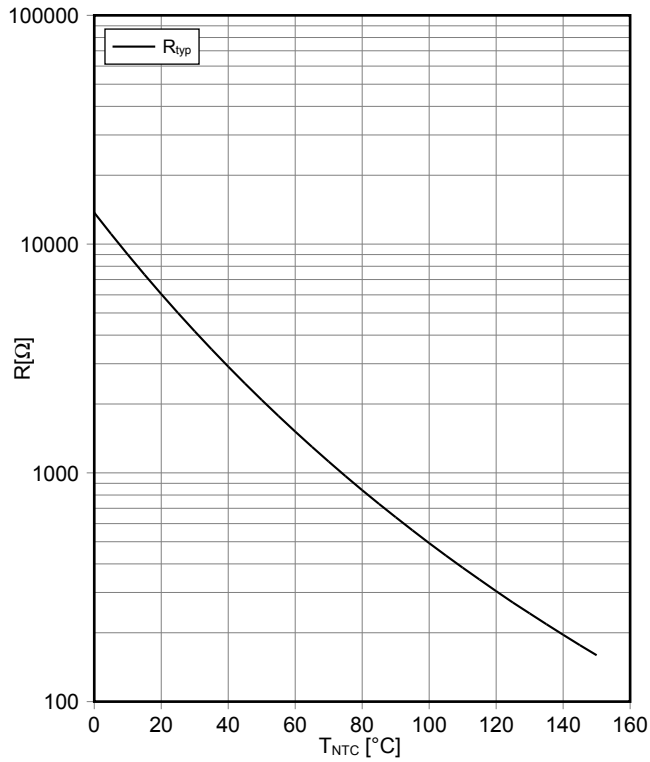
## Schaltverluste MOSFET (typisch) switching losses MOSFET (typical)

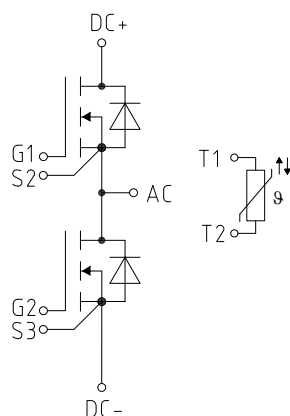
 $E_{on} = f(I_D), E_{off} = f(I_D)$ 
 $V_{GS} = -5\text{ V} / 15\text{ V}, R_{Gon} = 1\ \Omega, R_{Goff} = 1\ \Omega, V_{DS} = 600\text{ V}$ 


## Schaltverluste MOSFET (typisch) switching losses MOSFET (typical)

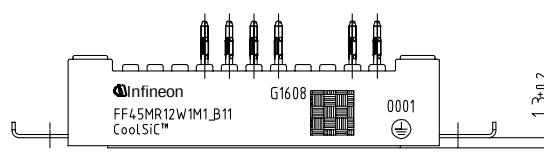
 $E_{on} = f(R_G), E_{off} = f(R_G)$ 
 $V_{GS} = -5\text{ V} / 15\text{ V}, I_D = 25\text{ A}, V_{DS} = 600\text{ V}$ 


**NTC-Widerstand-Temperaturkennlinie (typisch)**  
**NTC-Thermistor-temperature characteristic (typical)**  
 $R = f(T)$

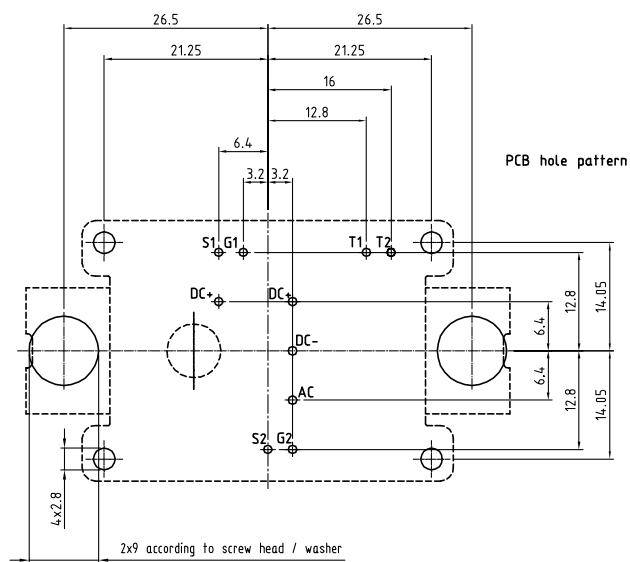
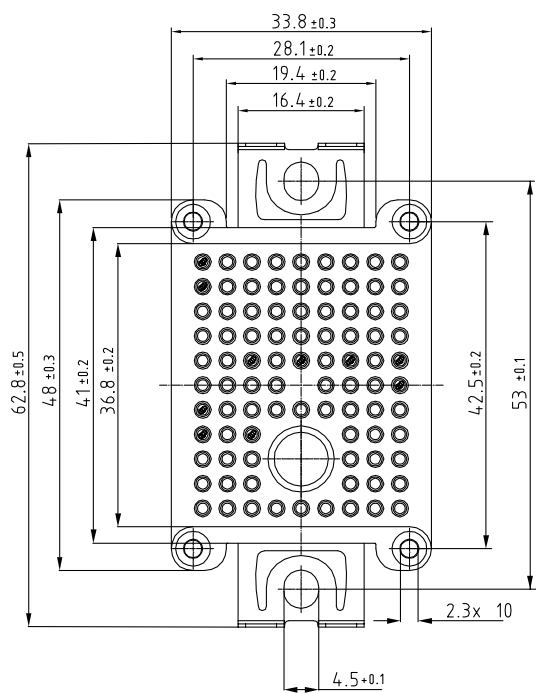




Technical drawing of a stepped shaft. The drawing shows a shaft with a step. The total length of the shaft is dimensioned as  $16.4 \pm 0.5$ . The length of the section with the step is dimensioned as  $12 \pm 0.35$ . The shaft is shown in a cross-sectional view, with a central hole. The drawing is labeled with '16.4 ± 0.5' and '12 ± 0.35'.



- Pin-Grid 3.2mm
  - Tolerance of PCB hole pattern   $\phi 0.1$
  - Hole specification for contacts see AN 2009-01
  - Diameters of drill  $\phi$  1.15mm
- and copper thickness in hole 25-50 $\mu$ m



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